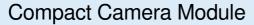


DATA SHEET (DOC No. HM01B0-MNA-00FT870-DS)

^{>>}НМ01В0-МNА-00FT870

Compact Camera Module Preliminary version 01 Oct, 2019

Himax Imaging, Ltd.



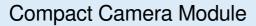


Revision History

Oct. 2019

Version	Date	Description of changes	
01	2019/10/09	New setup.	



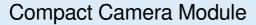




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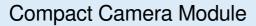


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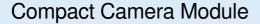




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Important Notice

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^{>>}HM01B0-MNA-00FT870

Compact Camera Module



Preliminary Version 01

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1. Sensor Specification

The HM01B0 is an Ultra Low Power Image Sensor (**ULPIS**) that enables the integration of an "Always-on" camera for computer vision applications such as gestures, intelligent ambient light and proximity sensing, tracking and object identification. The unique architecture of the sensor enables the sensor to consume very low power of <4mW at QVGA 60FPS, <2mW at QVGA 30FPS, and <1.1mW at QQVGA 30FPS.

The HM01B0 contains 324 x 324 pixel resolutions and supports a 324 x 244 window mode which can be readout at a maximum frame rate of 60FPS, and a 2x2 monochrome binning mode with a maximum frame rate of 120FPS. The video data is transferred over a configurable 1-bit, 4-bit or 8-bit video interface with support for frame and line synchronization. The sensor integrates a black level calibration circuit, automatic exposure and gain control loop, self-oscillator and motion detection circuit with interrupt output to reduce host computation and commands to the sensor to optimize the system power consumption.

The sensor is available in a Chip Scale Package (CSP) or Bare Die and measures less than 5mm². The sensor supports single, dual or triple power supply configuration and requires only 3 passive components enabling a highly compact camera module design for devices such as IoT, wearable, smart building, smart phone, tablets and slim notebooks.



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1.1 Features

- Ultra Low Power Image Sensor designed for Always-on vision devices and applications
- High sensitivity 3.6μ BrightSenseTM pixel technology
- 324 x 324 active pixel resolution with support for QVGA window, vertical flip and horizontal mirror readout
- <1.1mW QQVGA resolution at 30FPS,
 < 2mW QVGA resolution at 30FPS
- Programmable black level calibration target, frame size, frame rate, exposure, analog gain (up to 8x) and digital gain (up to 4x)
- Automatic exposure and gain control loop with support for 50Hz / 60Hz flicker avoidance
- Flexible 1-bit, 4-bit and 8-bit video data interface with video frame and line sync
- Motion Detection circuit with programmable ROI and detection threshold with digital output to serve as an interrupt
- On-chip self oscillator
- I2C 2-Wire serial interface for register access
- CSP and Bare Die sensor package option
- High CRA for low profile module design

1.2 Application

- Cellular and mobile phones
- Digital video camcorders
- PC multimedia
- Tablets





1.3 Key parameters

Module Parameters	Value					
Image sensor part number	HM01B0-MNA					
Pixel Array (Active/ Effective)	324 x 324 / 320 x 320					
Pixel Size	3.6µm x 3.6µm					
Image Diagonal	1.63mm					
Optical Format	Full frame 1/11"; QVGA 1/13"					
Color Filter Array	Bayer, Monochrome					
Shutter Type	Electronic Rolling Shutter					
Frame Rate (Max.)	8-bit, 320p 45FPS @ 6MHz					
(8-bit interface)	8-bit, QVGA 60FPS @ 6MHz					
Frame Rate MAX	8-bit, 320p 45FPS @ 12MHz					
(4-bit interface)	8-bit, QVGA 60FPS @ 12MHz					
Frame Rate MAX	8-bit, 320p 30FPS@ 36MHz					
(1-bit interface)	8-bit, QVGA 45FPS @ 36MHz					
S/N Ratio _{MAX}	38.7dB					
Dynamic Range (1x / 8x)	64dB / 70dB					
Sensitivity @ 530nm	5.6 V / Lux-sec					
Pixel CRA MAX	30°					
	AVDD 2.8V					
Supply Voltage (Typ.)	DVDD 1.5V					
	IOVDD 1.8 / 2.8V					
Input Reference Clock	3 – 36MHz					
Serial Interface	I2C, 400kHz max.					
Video Data Interface 8-bit, 4-bit, 1-bit data output						
	FVLD, LVLD, PCLK					
Pixel Clock (PCLK) (MAX.)	36MHz					
Output Format	6-bit / 8-bit RAW					
Digital Output	Motion Interrupt (Active High)					
Control Loop	Black Level, Exposure / Gain					
1	8-bit, QQVGA 30FPS 1.1mW					
Device Consumention (Top)	8-bit, QVGA 30FPS <2mW					
Power Consumption (Typ.)	8-bit, QVGA 60FPS <4mW					
6/0/	Standby 200µW					
Temperature	Operating -20 °C to 85 °C					
	Stable Image 0 °C to 60 °C					
Construction	3P+ CG					
EFL	0.66 mm ± 5%					
BFL	1.04 mm					
Image circle	1.83 mm					
F/No TV distortion	2.4					
TV distortion	under 4.3% Horizontal 87°					
Field of view	Vertical 87°					
	Diagonal 115°					
Relative illumination	Over 35%: y=1.0d					
Chief ray angle	30°					
Barrel size	M3.5 x P0.20					
Holder size Total track (Barrel to image)	5.0mm x 5.0mm Y=2.80 ± 0.1 (at inf.)					
TOTAL LIAUN (DAITEL TO IIIIAYE)	1-2.00 ± 0.1 (at IIII.)					



1.4 QVGA window readout

The QVGA sensor window with an active resolution of 324 x 244 pixels is programmed by setting register 0x3010[0] to 1. The location of the windows fixed such that the coordinate of the first pixel read out location is 0, 0.

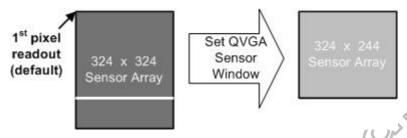


Figure 1.1: QVGA resolution pixel readout





1.5 Electrical specification

1.5.1 Operating ratings

Parameter	Symbol		Spec.		
Parameter	Symbol	Min.	Тур.	Max.	Unit
Analog supply voltage	V_{DD-A}	2.6	2.8	3.0	V
Digital supply voltage	V_{DD-D}	1.35	1.5	1.65	V
IO supply voltage	$V_{DD ext{-}IO}$	1.7	1.8	3.0	V

Table 1.1: Operating ratings

1.5.2 DC characteristics

The power consumptions are measured in sense ($C_L = 5pF$).

			Spec.					
Parameter	Symbol	Condition	Min. Typ.		Max.	Unit		
Avenage Current Concur	nntion .		IVIIII.	Typ.	IVIAX.			
Average Current Consumption								
	I _{DD-AVDD1}	External Internal LDO Mode, 8-bit RAW, QVGA @ 60FPS,	Ja- C	271	-	μΑ		
Active current 1	I _{DD-DVDD1}	PCLKO gated,	on?	1201	-	μΑ		
	I _{DD-IOVDD1}	$V_{DD-A} = 2.8V, V_{DD-D} = 1.5V,$ $V_{DD-IO} = 1.8V$		287	-	μΑ		
Add a second O	I _{DD-AVDD2}	Internal LDO Mode, 8-bit RAW, QVGA @ 60FPS,	<u> </u>	278	-	μΑ		
Active current 2	I _{DD-IOVDD2}	PCLKO gated, V _{DD-A} = 2.8V, V _{DD-IO} = 2.8V	7 (0)	1746	-	μΑ		
Standby current 1	IDD-STANDBY1	External Internal LDO Mode, $V_{DD-A} = 2.8V$, $V_{DD-D} = 1.5V$, $V_{DD-IO} = 1.8V$, MCLK on	D -	105.7	-	μΑ		
Standby current 2	IDD-STANDBY2	External Internal LDO Mode, V _{DD-A} = 2.8V, V _{DD-D} = 1.5V, V _{DD-IO} = 1.8V, MCLK off	-	3	-	μΑ		
Standby current 3	IDD-STANDBY3	Internal LDO Mode, V _{DD-A} = 2.8V, V _{DD-IO} = 2.8V, MCLK on	-	142.3	-	μΑ		
Standby current 4	IDD-STANDBY4	Internal LDO Mode, VDD-A = 2.8V, VDD-IO = 2.8V, MCLK off	-	25.1	-	μΑ		
Digital Inputs (MCLK, TR	IIG, SCL)							
Input voltage low	VIL	-	GND – 0.3	-	0.3V _{DD-IO}	٧		
Input voltage high	VIH	-	0.7V _{DD-IO}	-	V _{DD-IO} + 0.3	٧		
Input capacitance	CIN	-		4	-	pF		
Digital Output								
Output voltage low	V_{OL}	-	-	-	$0.2V_{DD-IO}$	V		
Output voltage high	V _{OH}	-	$0.8V_{DD-IO}$	-	-	V		
Output capacitance	Соит	-	-	4	-	pF		
Output resistance	Rout	-	-	1	-	Ω		
Tri-state leakage current	l _{OZ}	-	-	-	10	μΑ		

Table 1.2: DC characteristics

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1.5.3 Master clock input (MCLK)

Parameter	Symbol	Condition	Spec.			Unit
Parameter	Syllibol	Condition	Min.	Тур.	Max.	Ullit
Input frequency	MCLK	-	3	-	36	MHz
Input clock duty cycle	MCLK _{DUTY}	-	45	-	55	%

Table 1.3: Master Clock (MCLK) timing





1.6 Power up sequence

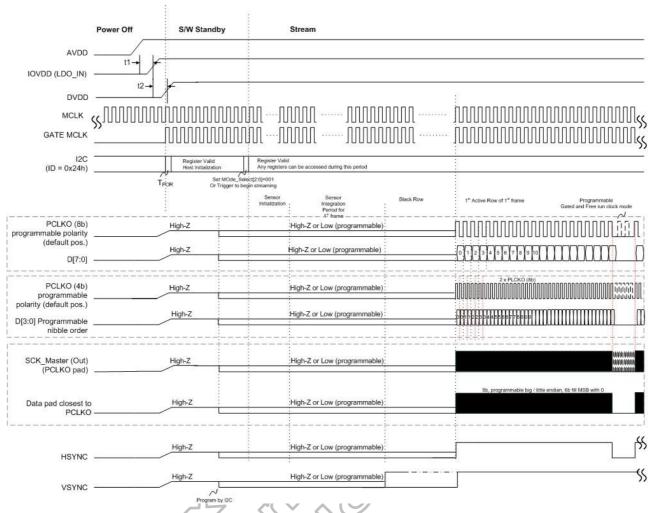


Figure 1.2: Power up sequence

Parameter	Symbol	Spec.			Limit
raiailletei		Min.	Тур.	Max.	Unit
AVDD to IOVDD	t1	0	-	∞	S
IOVDD to DVDD	t2	0	1	∞	S
Power On Reset time	tpor	50	-	-	μs

Table 1.4: Power up sequence timing



2. Camera Module Specification

2.1 Pin map and description of camera module

AGND		
	Ground	Analog ground.
AVDD28	Power	Analog power. (2.8V)
DGND	Ground	Digital ground.
TRIG	In	Frame trigger input. (Internal pull down / Active high)
FLVD	Out	Frame valid output.
LVLD	Out	Line valid output.
SCL	In	I2C serial clock.
SDA	In/Out	Serial data I/O. (Open drain)
INT	Out	Interrupt output. (Active high)
DGND	Ground	Digital ground.
IOVDD18	Power	IO power. (1.8V)
DVDD15	Power	Core digital power. (1.5V)
DGND	Ground	Digital ground.
MCLK	In	Master clock input.
DGND	Ground	Digital ground.
PCLK	Out	Pixel clock
D0	Out	Data 0 output.
D1	Out	Data 1 output.
D2	Out	Data 2 output.
D3	Out	Data 3 output.
D4 (7)	Out	Data 4 output.
D5	Out	Data 5 output.
D6	Out	Data 6 output.
D7	Out	Data 7 output.
	DGND TRIG FLVD LVLD SCL SDA INT DGND IOVDD18 DVDD15 DGND MCLK DGND PCLK D0 D1 D2 D3 D4 D5 D6 D7	DGND Ground TRIG In FLVD Out LVLD Out SCL In SDA In/Out INT Out DGND Ground IOVDD18 Power DVDD15 Power DGND Ground MCLK In DGND Ground PCLK Out D0 Out D1 Out D2 Out D3 Out D4 Out D5 Out

Note: (1) HM01B0 sensor default slave address: 0x24.

Table 2.1: Pin map and description of camera module

2.2 Mechanical drawing of camera module

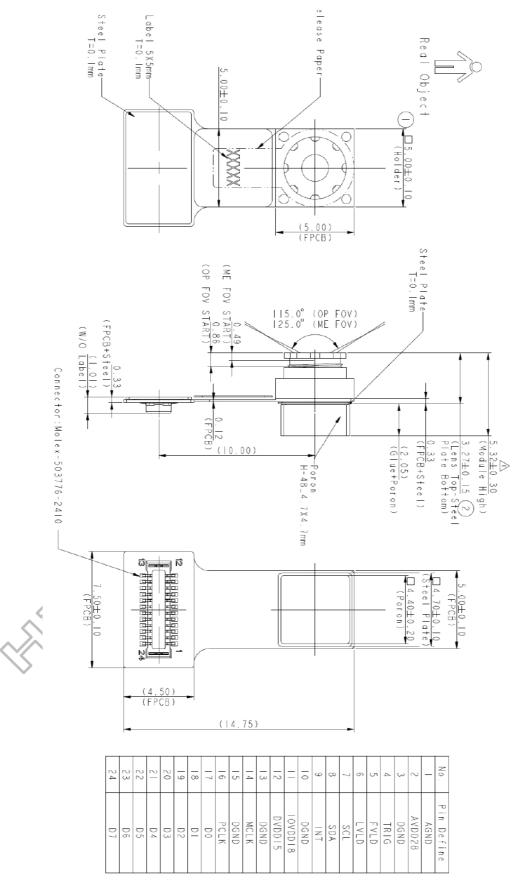


Figure 2.1: Mechanical drawing of camera module

2.3 Application schematic of camera module

2.3.1 Reference circuit

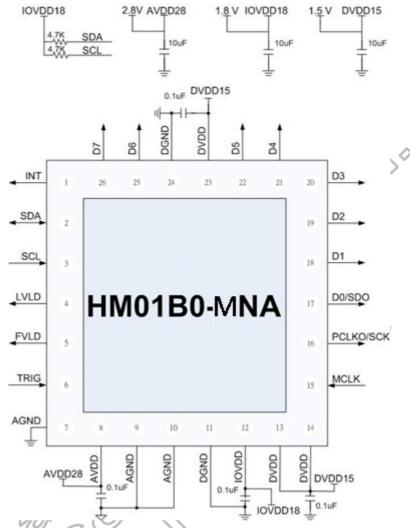


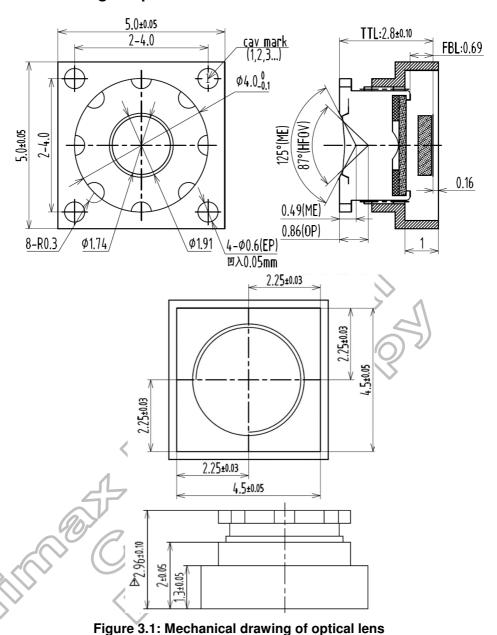
Figure 2.2: Reference circuit of camera module

2.3.2 Layout consideration

- A. In order to reduce power noise to the camera module, it is suggested that a 0.1µF capacitor and a high value decoupling capacitor (10µF or above) be placed across every power line (AVDD & DVDD & IOVDD) and corresponding ground pin. Try to place these capacitors close to the module connector. The power noise will contribute to image noise and it is necessary to reduce them as much as possible.
- B. In order to reduce interference and noise caused by the high frequency clocks. It is suggested that the master and pixel clocks be surrounded with ground shielding pins.
- C. In order to avoid the ground loop, it is recommended that the sensor analog ground be connected to sensor digital ground through a point or 00hm resistor. Then the sensor digital ground should be connected to system ground through a point or a 0 ohm resistor.
- D. In order to reduce EM radiation, it is recommended that ground pins be assigned to the edge of the module connector.

3. Optical Lens Specification

3.1 Mechanical drawing of optical lens



3.2 Specification of optical lens

Specification	Description
CONSTRUCTION	3P+CG
EFL	0.66 mm
F/NO	2.4
OP FIELD OF VIEW (Diagonal)	115°
TV DISTORTION	-4.3%
RELATIVE ILLUMINANCE	35%
MAX CHIEF RAY ANGLE	30°

Table 3.1: Lens optical specification



4. Image Quality Specification

No.	Test Item	Diagram	Test Condition	Standard	
1	MTF		Test Chart: 1/8 N Pattern Chart Distance: 35cm Full Image Size	Center(0% field) : >=0.8 Corner(65% field) : >=0.6	
2	Shading	AOI:32x32 pixel Shading Ratio= Ycorner(min) / Ycenter	Without ISP (raw image) Distance : 1cm Light condition : 1500 +/- 300 lux , 5100+/-300K	>=30%	
3	Blemish	A: 324pixel B: 324pixel Block Size: 9x9 pixel	Without ISP (raw image) Distance : 1cm Light condition : 1500 +/- 300 lux , 5100+/-300K	The liminance difference between each block and the adjacent block should be less than 3%	
		Dark Pixel Defect	The sensor is illuminated to midlevel : ~ 400 LSBs to 700 LSBs.	Within a color plane, each pixel is compared to the mean of the neighboring 40 x 40 pixels. If the pixel value is 40 percent or more below the mean, it is considered a dark pixel defect.	
4	Defect pixel	Derect	Bright Pixel Defect	The sensor is illuminated to midlevel: ~ 400 LSBs to 700 LSBs. (Analog gain = 1; exposure time = 10ms)	Within a color plane, each pixel is compared to the mean of the neighboring 40 x 40 pixels. If the pixel value is 40 percent or more above the mean, it is considered a dark pixel defect.
		Bright Cluster Defect No. : 10	By "Bright Pixel Defect" Result	The defects within each color plane are examined. If any two adjacent pixels that are considered bright pixel defects are detected, they are then defined as a bright cluster. The defects within a color	
		Dark Cluster Defect No. : 10	By "Dark Pixel Defect" Result	plane are examined. If any two	

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	adjacent pixels that are considered dark pixel defects are detected, they are then defined as a dark cluster.

Table 4.1: Image Quality Specification



5. Reliability Test Conditions

5.1 Test Unit:

Reliability test Q'ty: 35 pcs

5.2 Test Condition

No.	Test Item	Test Conditions	Judgement
1	High Temperature test	60°C / 48 hrs	
2	High Temperature & Humidity test	60℃ / 90%RH	
_	riigii remperatare a riamany test	48hrs	
3	Low Temperature test	-20℃ / 48 hrs	
4	Thermal Shock test	-20°C / 30min∼60°C / 30min	
-	(No-Operating)	32 cycles	
5	ESD test	Contact discharge: ±2.0 KV / 10 times, to USB	The difference of
	(No-Operating)	connector Human Body Mode	MTF(%)
	Mechanical Vibration test	5Hz~350Hz~500Hz	Center <=5 Corner(0.7f)
6		0.21 Grms.	
	(10 Sporamig, 10 paskaging)	Vibrate X,Y, and Z axis, 60min per axis.	<=10
7	Mechanical Vibration test	5Hz~55Hz; -6dB;	
'	(No-Operating, packaging)	Acc 3G, Vibrate X,Y, and Z axis, 60min per axis.	
8	Drop test	80cm height free fall for 10 times per unit	
	(No-Operating, No packaging)	base material: concrete floor	
	Drop test	100cm height free fall for 10 impacts per unit (1	
9	(No-Operating, packaging)	corner, 3 edges, 6 faces)	
	(is a political passing)	base material: concrete floor	

Table 5.1: Reliability test condition

6. Inspection Specification

6.1 Sampling Plan

MIL-STD-105E Level single normal random sampling Defect classification and AQL

Category	Dimension, appearance	Image function
AQL	AQL = 0.65	AQL = 0.4

6.2 Visual Inspection Method

Lighting: the light level in QC station is 500~800 Lux

Location: test sample should put in front of inspector for 30cm±5cm

View angle: 90±15 degree

6.3 Inspection Item

Appearance and dimension check Image function inspection

6.4 Remark

This standard is a general. If any special case (ex; specified component .. etc), it should be created a related standard and keep it was updated. If any Dept. or customer ahs special request, we will use this request temporarily until it was canceled by Dept. or customer.

6.5 Appearance and Dimension Check

Cate.	No.	Item	Specification	Picture
Product	1	Please follow	Please reference ME	Please reference ME drawing
outline		ME drawing	drawing	
Product	1	Lens glue	1. No protruded glue	This is not the correct model,
appearance		overflow	residue on the	Only for understanding
		Barrel damaged	Lens/Barrel surface 2. Barrel can be not damaged	
	2	Lens scratch	1. length ≦ 0.5D of	This is not the correct model,
			lens	Only for understanding
			2. can be not influence image	
	3	Barrel scatch	1. length ≦ D	This is not the correct model,
			2. length ≥ 1/2D	Only for understanding



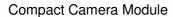
			DATASHEET Preliminary V01
4 5	FPCA burr Barrel loose	allow 2 places 3. can't be across center area <0.2mm and can't mak Barrel lossed is unacceptable	e the outline dimension out of spec. Confirmation method: use the clean needle to see if UV glue is cured completely.
7	Holder mount gap Solder mask damage	1. can't make the outline dimension out of spec. 2. can't influence image Circuit or inner material exposure is not acceptable	This is not the correct model, Only for understanding This is not the correct model, Only for understanding
8	FPC dirty or glue residue	Length (or 2Radius) of the dirty or glue residue < 1/5 th3 samllest edge length	This is not the correct model, Only for understanding
9	FPC printing	1. printing missing is NG	This is not the correct model, Only for understanding.





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 			DATASHEET Preliminary V01
		2. printing should be no blurred	
10	Connector	1. No solder ball and no solder residue 2. Pin oxidation is not acceptable 3. Pin damaged is not acceptable 4. Connector deformed and caused image problem is unacceptable	
11	Mylar attached	1. Mylar missing is NG 2. Mylar should be iin te same direction (same as PCB indicator) 3. Mylar is allowed to be shifted within a range of 45 degree; however, mylar lift-up is unacceptable	This is not the correct model, Only for understanding.
 12	Product label	1. Label missing is NG, should be no	This is not the correct model, Only for understanding.





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			DATASHEET FIEIHIIIIIAIY VUT		
Package	1	Packing	peeling, bubble, or blurred 2. Label is correct and clear and at right location	label	
1 ackage	1	1 acking	2. Packing material che	ok	
			3. Model mixing, materi		
			_	- /()×	
			Label is correct and clear and at right location Label should be no peeling, un-complete or blurred		
Function	1	Output	By visual		
T dilottori		Catput	Image not complete or no image is not acceptable		
	2	Abnormal	By visual		
		image	Image upside down, abnormal color or apart is unacceptable		
	3	Blurred image	By visual		
			Blurred, shading or other special image is unacceptable		
Image	1	Resolution	By test program		
quality		test	Images in center and 4 corners should be clear to identify the lines		
	2	Shading test	By test program		
			Ratio of darkest to center should be great than specified ratio.		
			(without lens correction)		
	3	Blemish	Both visual inspection and test by program are unacceptable		
	4	Defect pixel	Depend on test	Note: defect pixel definition follow sensor outgoing	
			program judgment	spec.	

7. Package Specification

7.1 Label List

Item	Label Name	Amount	Position
1	CT Label	1	Top of module
2	QA Label	2	Outside of package box
3	ROHS Label	3	PE BAG and outside of package box
4	Weight Label	3	PE BAG and outside of package box
5	PE Bag Label	2	PE BAG
6	Carton Label	1	Outside of package box

Table 7.1: List of package Label

7.2 Packing (the packaging process is only for understanding)

- 1. Put module into the tray, and accumulate trays together and then put an empty tray on the top side as a cap. Tray ties by tape. Put trays & exsiccate into PE Bag.
- 2. Put PE bags put into carton. Stick Logo label and ROHS label on the external box.



Figure 7.1: Packing of modules

Note:

If the full quantity is not enough to fill in the inner box, the empty tray should be used to fill into the box. No extra space can be in the box to protect the products safety in the transfer process.

7.3 Carton Packing Drawing

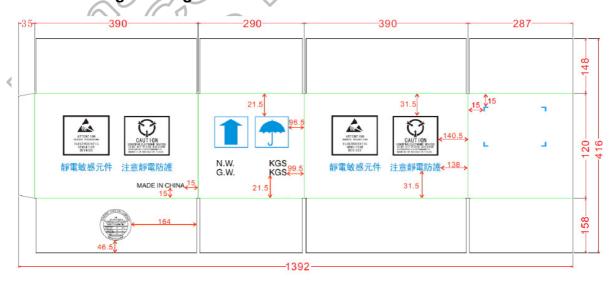


Figure 7.2: Carton packing drawing